

# ELECTRONIC MEASUREMENT & INSTRUMENTATION (BEC-29)



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**August, 2020**

# **UNIT-1**

## **Lecture 1**

### **Qualities, Measurements and Digital Display Devices**

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# Performance Characteristics of Instruments

- It is classified as: **Static** and **Dynamic**.
- **Static characteristics** are considered for instruments which are used to measure an unvarying process condition. These characteristics are obtained by a process called calibration.
- The **Static characteristics** have following parameters:
  - **Accuracy**: the degree of exactness of a measurement to a compared to a expected value.
  - **Resolution**: the smallest change in the measured value to which a instrument will respond.
  - **Precision**: a measure of consistency or repeatability of measurement i.e. successive values do not differ.
  - **Sensitivity**: the ratio of change in output of the instrument to a change in the input or measured value.
  - **Expected value**: the design value, i.e. the most probable value the calculations indicate one should expect to measure.
  - **Error** : the deviation of true value from the desired value.

# Dynamic Characteristics

- Is determined by subjecting its primary element to some unknown and predetermined variations in the measured quantity.
- The three most common variations are : step change, linear change and sinusoidal change.
- The dynamic characteristics are:
  - **Speed-** rapidity with which the instrument responds to change in measured quantity.
  - **Fidelity-** degree to which instrument indicates the change in measured quantity without any dynamic error.
  - **Lag-** delay in response of instrument with respect to the measured variable.
  - **Dynamic error** – difference between the true value of the quantity changing in time and the value indicated by the instrument, if no static error is assumed.

# Sources of Error

The sources of error other than a piece of inability of hardware is to provide a true measurement are:

- Insufficient knowledge of design conditions and process parameters.
- Poor design.
- Poor Maintenance.
- Error caused by person operating the instrument.
- Certain design limitations.

# Error in Measurements

- Measurement is the process of comparing an unknown quantity to an accepted standard quantity.
- The measurement is a quantitative measure of so called “True Value”.
- Some factors that affect the measurement are related to the measuring instrument itself. Other factors are related to person using the instrument.
- Error can be measured as absolute or percentage of error.
  - Absolute error is defined as the difference between the expected value of the variable and measured value of the variable.
    - $E = Y_n - X_n$
    - Where, E = absolute error
    - $Y_n$  = expected value
    - $X_n$  = measured value
    - Percentage of error =  $(\frac{E}{Y_n}) * 100 ; \frac{Y_n - X_n}{Y_n}$
    - It is expressed as accuracy rather than error.
    - Relative accuracy  $A = (1 - \frac{Y_n - X_n}{Y_n})$
    - Accuracy is expressed as percentage accuracy  $a = 100\% - \% \text{ error}$
    - $a = A * 100\%$

# Assignment Questions

- What do you understand by static characteristics?
- Define the terms : resolution, sensitivity and expected value.
- Define the terms : instrument, accuracy, precision and errors.
- Explain the gross error in detail. How it can be minimized?
- Explain systematic error in detail. How I can be minimized?

# Conceptual Questions

- The closeness of value indicated by an instrument to the actual value is defined as
  - (a) Repeatability (b) reliability (c) uncertainty (d) accuracy
- Precision is defined as
  - (a) Repeatability (b) reliability (c) uncertainty (d) accuracy
- The ratio of change in output to the change in input is defined as
  - (a) Precision (b) resolution (c) sensitivity (d) repeatability
- The deviation of the measured value to the desired value is defined as
  - (a) Error (b) repeatability (c) hysteresis (d) resolution
- Accuracy can be defined as
  - (a) Relative accuracy (b) % accuracy (c) error (d) % error

# Practice Problems

- A batch of  $3.3 \text{ K}\Omega$  resistors is measured as  $3.5 \text{ K}\Omega$  maximum and  $3.1 \text{ K}\Omega$  minimum. Specify the resistor tolerance, and the maximum absolute and relative errors.
- A  $5 \text{ K}\Omega$  potentiometer with a  $25 \Omega$  resolution is used as a voltage divider. If the potentiometer supply is  $12\text{V}$ , determine the precision of the output voltage.
- Calculate the maximum percentage error in the sum of two voltage measurements when  $V_1 = 100\text{V} \pm 1\%$  and  $V_2 = 80\text{V} \pm 5\%$ .
- Calculate the maximum percentage error in the difference of two voltage measurements when  $V_1 = 100\text{V} \pm 1\%$  and  $V_2 = 80\text{V} \pm 5\%$ .

**THANK YOU**